



**Fundusze Europejskie**  
Wiedza Edukacja Rozwój



**Rzeczpospolita  
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Europejski Fundusz Społeczny



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opartego o badania i innowacje**

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# **Digital Circuits Design**

**Faculty of Automatic Control, Electronics and Computer Science,  
Informatics, Bachelor Degree**

# Lecture 1

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## Digital IC Parameters – part 1

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# Parameters – part 1

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Program:

(today)

- Parameter groups
- Functional parameters
- Dynamic parameters

(next week)

- Static parameters
- Operational conditions parameters
- Clock asynchronism, example values

# Parameters – part 1

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- Properties of digital IC are described by external parameters
  - Proper choice of IC
  - Optimal properties utilisation
- Digital IC's production
  - Large series, constant proces
  - Various applications
  - Various conditions
- Full exchangeability rule
  - An IC can be replaced with another one of the same type without influence on device operation
  - No preselection of IC's is necessary

# Parameters – part 1

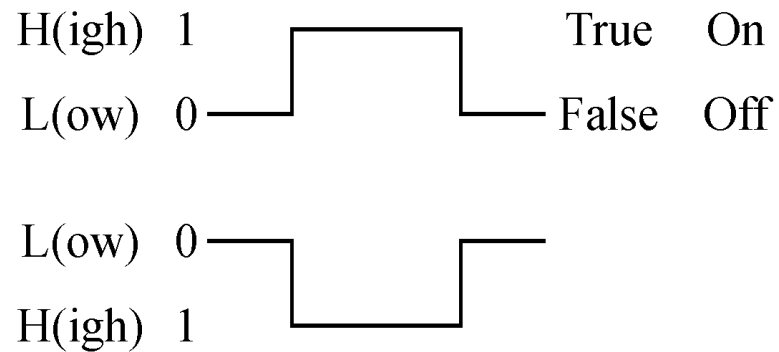
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- Parameter groups
  - Functional parameters
    - Describe functional IC properties
  - Dynamic parameters
    - Time dependencies
  - Static parameters
    - Voltage levels, current values, cooperation conditions
  - Parameters describing IC operating conditions
    - E.g., power supply, temperature, humidity, etc.

# Parameters – part 1

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- Functional parameters
  - Logic, arithmetic function of IC
  - Logic convention must be accepted first
    - Positive convention – most of digital IC's
      - TTL
      - CMOS
    - Negative convention
      - RS-232
      - ECL



# Parameters – part 1

## – Inputs influence on each other and on the circuit

- Inputs:

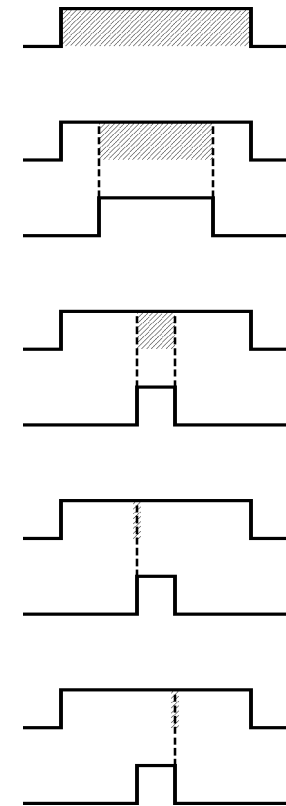
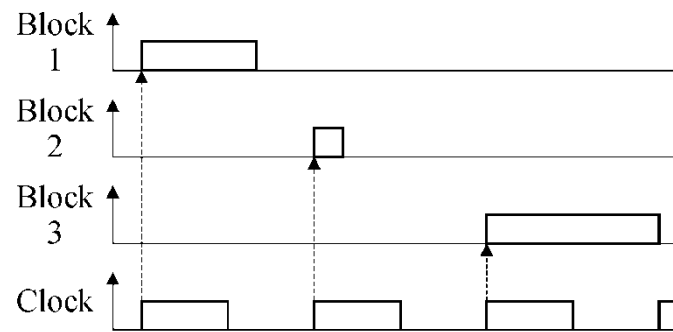
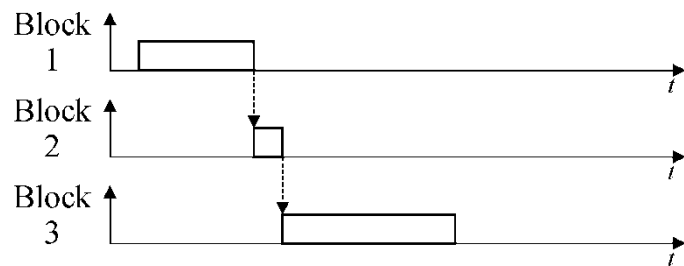
- Information (data to be processed; syn/asyn)
- Control (function to be performed; syn/asyn)
- Synchronisation (clock)

- Signal synchronism

- Asynchronous – signal influences all the time it's active
- Synchronous – signal influences only at the moments specified by clock

- Device synchronism

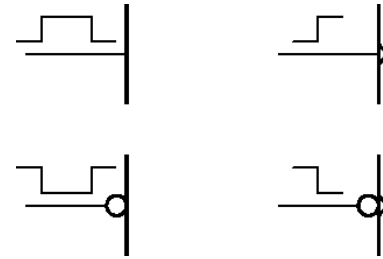
- Asynchronous – once a block finishes its task, the next one can start immediately
- Synchronous – the next block can start a task only at the moment specified by clock



# Parameters – part 1

– Inputs influence on the circuit

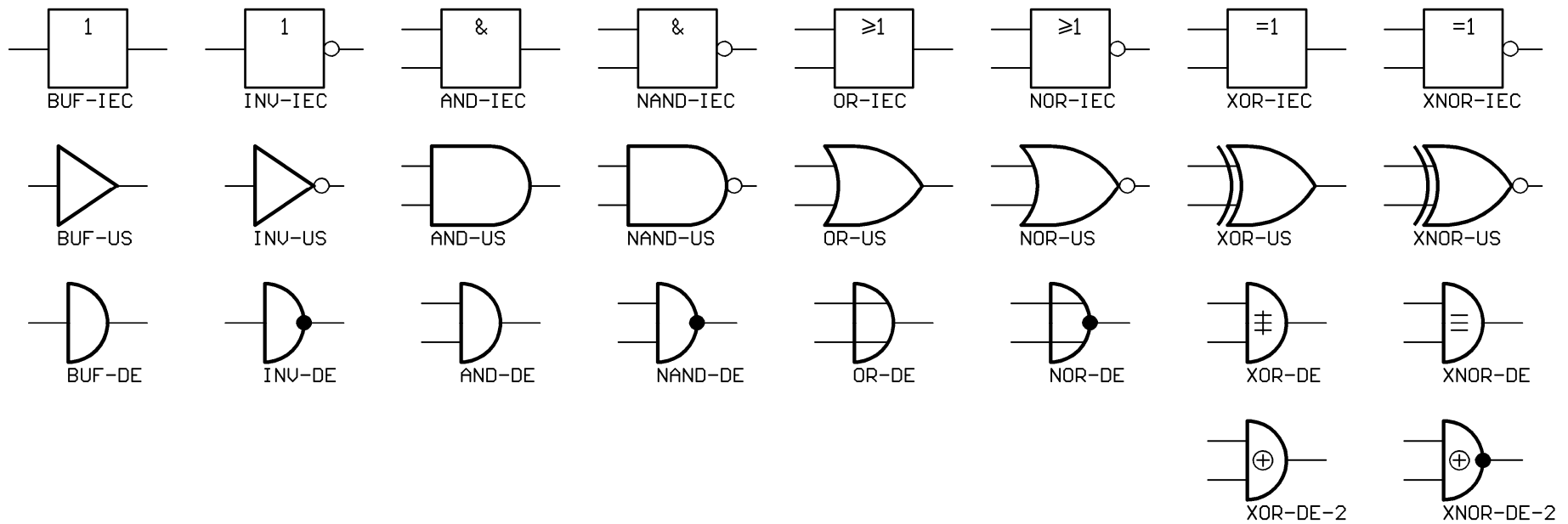
- Level sensitive
- Edge/sequence of edges sensitive



– Input/output marking on the diagram

– Gates and other elements symbols

- Few different standards





# Parameters – part 1

- Gates and other elements symbols

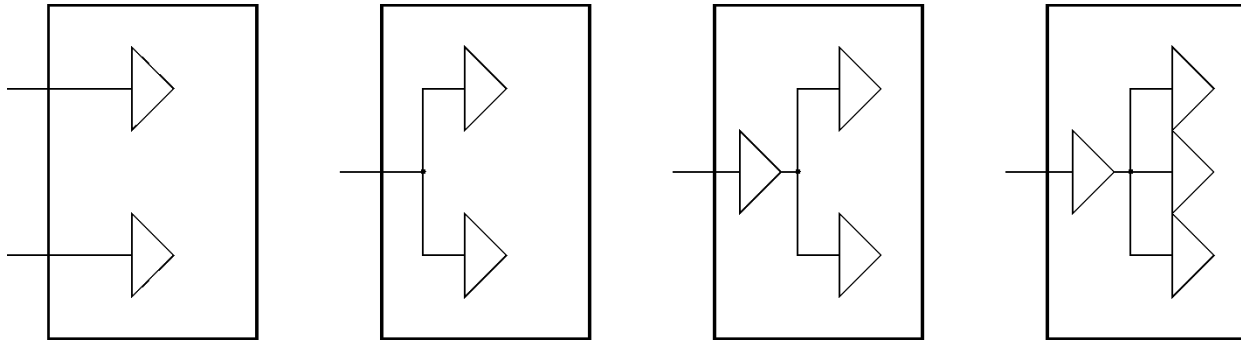
Logic function	American (MIL/ANSI) Symbol		British (BS3939) Symbol		Common German Symbol		International Electrotechnical Commission (IEC) Symbol	
	IN	OUT	IN	OUT	IN	OUT	IN	OUT
Buffer								
Inverter (NOT gate)								
2-input AND gate								
2-input NAND gate								
2-input OR gate								
2-input NOR gate								
2-input EX-OR gate								
2-input EX-NOR gate								

# Parameters – part 1

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## – Unit load:

- Load caused by a single input of a standard logic gate in a given technology
- Makes sense only if all the elements belong to the same family
- If an input controls more internal signals, the load is a multiple of the unit load



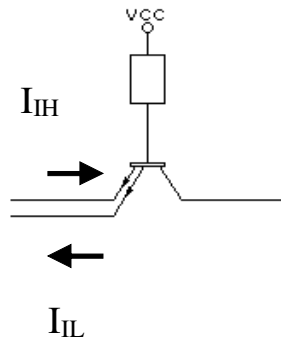
## – Outputs

- Load (logic gain) – number of inputs of IC belonging to the given family, that can be driven by the output without exceeding/violating its parameters
- Typical logic gain = few to over a dozen
- Output types
- Possibility of output connecting

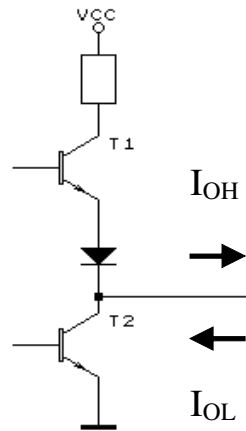
# Parameters – part 1

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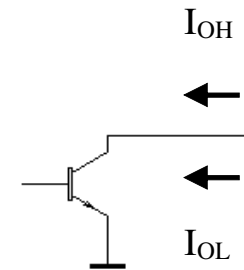
- Inputs and outputs



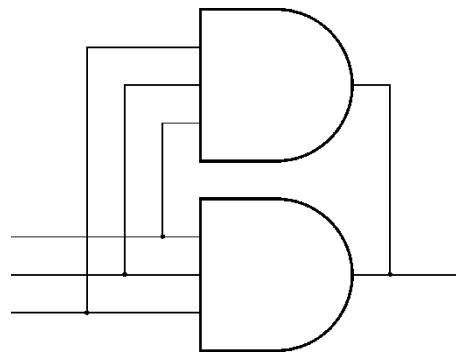
input



totem-pole output

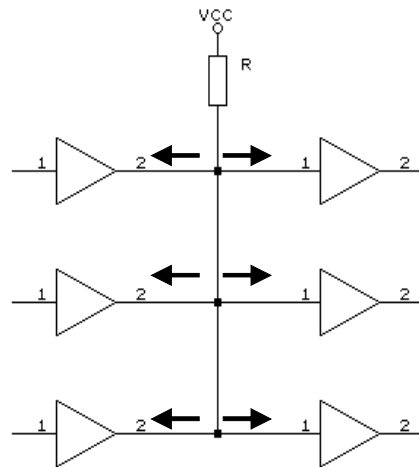


open-collector output

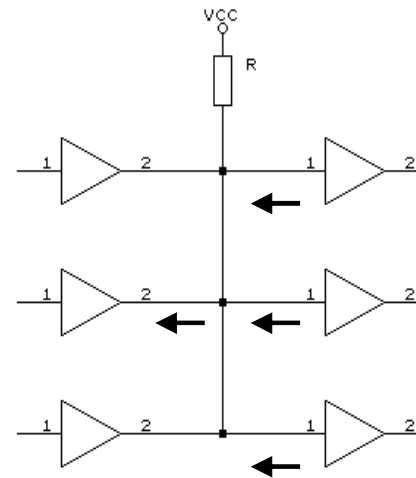


# Parameters – part 1

- Resistor value calculation for open-collector outputs



High state



Low state

$$R_{max} = \frac{VCC - \max(U_{OHmin}, U_{IHmin})}{\sum I_{OHmax} + \sum I_{IHmax}}$$

$$R_{min} = \frac{VCC - \min(U_{OLmax})}{\min(I_{OLmax}) - \sum I_{ILmax}}$$

# Parameters – part 1

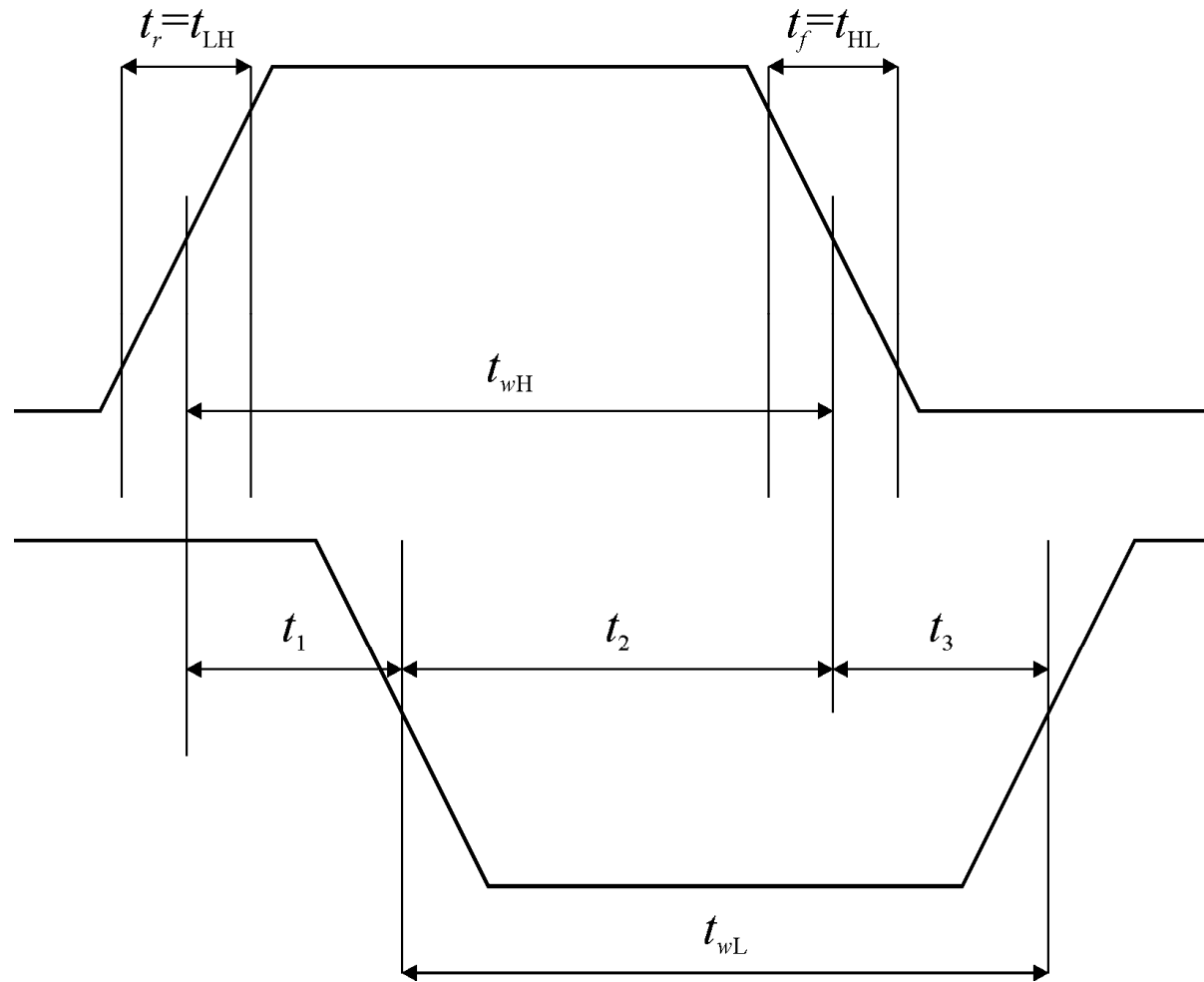
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- Dynamic parameters
  - Dependencies between input and output signals
    - Corresponding to inputs → determine input driving conditions
    - Relations between inputs and outputs → determine circuit switching speed
  - Non-uniform production, various operating conditions → value ranges rather than exact values
  - Often only min, max and typical (e.g., average) values are given
  
  - „time rise” ( $t_r$ ) and „time fall” ( $t_f$ ) measured between:
    - 10% and 90% of amplitude
    - 20% and 80% of amplitude
    - Some constant  $U_a$  and  $U_b$
  - Time between two edges measure between:
    - 50% to 50% of amplitude
    - Some constant  $U_c$
    - Switching threshold voltage

# Parameters – part 1

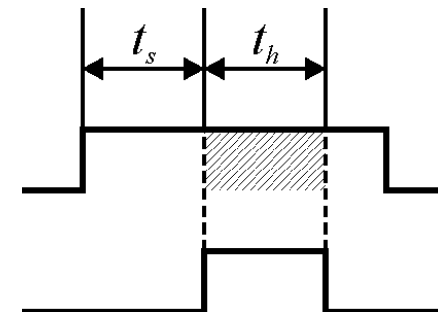
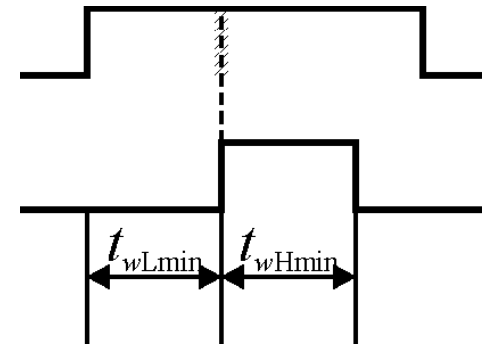
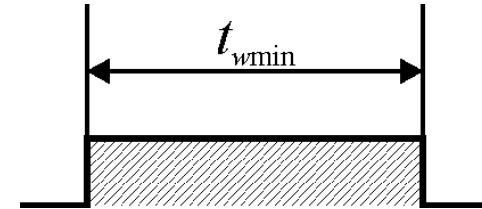
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- An illustration of dynamic parameters



# Parameters – part 1

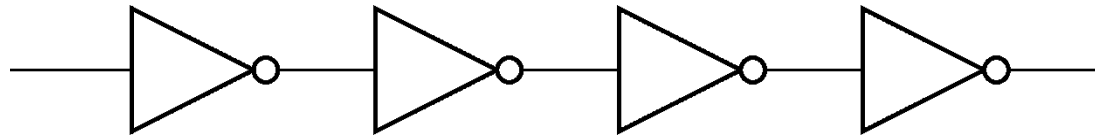
- About dynamic parameters
  - Syn/asyn level sensitive input
    - $t_{wmin}$
  - Edge synchronising input
    - $t_{wLmin}$  (before edge),
    - $t_{wHmin}$  (after edge),
    - $t_{rmax}, t_{fmax}$  (max edge duration)
  - Synchronous level sensitive input  $\rightarrow t_s$  („time set“),  $t_h$  („time hold“)
  - Synchronisation input (clock)  $\rightarrow f_{max}$  (*de facto* minimal frequency guaranteed)



# Parameters – part 1

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- Propagation time – from input signal change to the effect visible at the output signal
  - Usually only max value → guaranteed not to be exceeded
  - sometimes typical value → the value we can hope for (not guaranteed)
  - Very rarely min value → not necessary for digital system design (except some really special cases...)



$$\Delta t \in \left\langle \sum t_{p_{min}} \dots \sum t_{p_{max}} \right\rangle$$